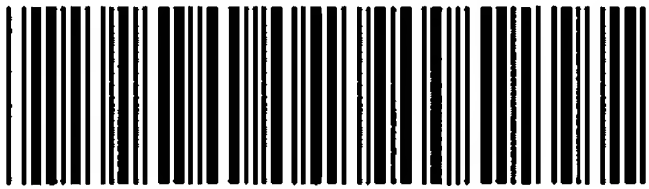


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/621,908	DHONG ET AL.	
	Examiner	Art Unit	
	Benjamin P. Geib	2181	

SEARCHED			
Class	Subclass	Date	Examiner
712	22	1/3/2006	BPG
712	221	1/3/2006	BPG

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East Search	1/3/2006	BPG
IEEE Xplore Search	1/4/2006	BPG
ACM Search	1/4/2006	BPG